



**Significant increase of QE
is opening
new avenues
for standard photodetectors**

**by C. Fontaine
PHOTONIS France**



1. Interest of high QE
2. QE is key for new devices
3. Higher QE always existed
4. How to increase intrinsic photocathode QE ?
5. Improving overall QE of photodetectors ?
6. Conclusion



- Visible light can react and become measurable by:
 - ◆ Eye (*human: $QE \sim 3\%$ & animal*), plants, paints,...
 - ◆ Photoemulsion ($QE \sim 0.1 - 1\%$) (photo-chemical)
 - ◆ Photodiodes (photoelectrical, evacuated)
 - ◆ Classical & hybrid photomultipliers ($QE \sim 25\%$)
 $QE \sim 45\%$ (HPD with GaAsP photocathode)
 - ◆ Photodiodes ($QE \sim 70 - 80\%$) (photoelectrical)
 - ◆ PIN diodes, Avalanche diodes, SiPM,...
 - ◆ photodiode arrays like CCD, CMOS cameras,...



The photocathode is the first statistical process of the detection chain

For light detection :
it is the first one to convert the photon statistics

For radiation detection :
it is the first one to convert the photon statistics after
the scintillator conversion of gamma rays into photons

It means QE is key for :

- Energy resolution
- Coincidence timing

... but there are other very important parameters not to forget



Definition is easy :

$$QE \equiv \frac{(\# \text{ Emitted } _ \text{ Photoelectrons})}{(\# \text{ Incident } _ \text{ Photons})}$$

$$= \frac{N_{pe}}{N_{\gamma}}$$

Many underlying factors :

$$QE \approx \left(1 - P_{rob_of_refelection}\right) \left(1 - P_{rob_Absorption_in_Window}\right)$$

$$\times \left(1 - e^{-\frac{d}{2 \cos \alpha \cdot L_{photon}}}\right) \cdot P_{rob_of_Electron_Excitation}$$

$$\times e^{-\frac{d}{2 \cos \beta \cdot L_{electron}}} \cdot P_{rob_of_Electron_Emission}$$

d : Thickness of Alkali Material
 α : Incident Photon Angle
 β : Emitted Electron Angle



d : Thickness of Alkali Material - α : Incident Photon Angle - β : Emitted Electron Angle

Optimisation before photons reach the window

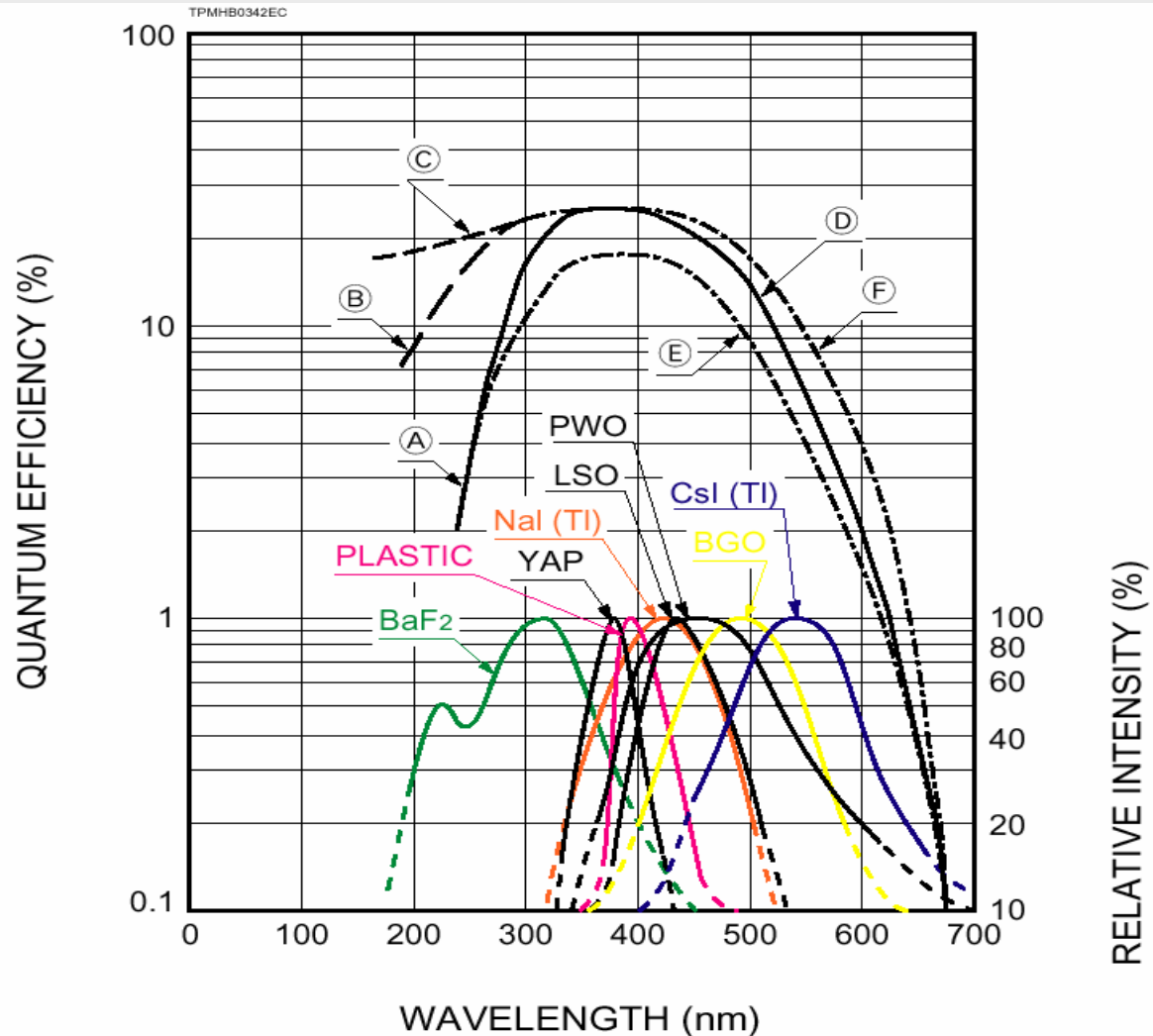
Optimisation when photons enter the window

$$\begin{aligned}
 QE \approx & \left(1 - P_{rob_of_refelection}\right) \left(1 - P_{rob_Absorption_in_Window}\right) \\
 & \times \left(1 - e^{-\frac{d}{2 \cos \alpha \cdot L_{photon}}}\right) \cdot P_{rob_of_Electron_Excitation} \\
 & \times e^{-\frac{d}{2 \cos \beta \cdot L_{electron}}} \cdot P_{rob_of_Electron_Emission}
 \end{aligned}$$



- (A): Borosilicate Glass
- (B): UV Glass
- (C): Synthetic Silica
- (D): Bialkali Photocathode
- (E): High Temp. Bialkali Photocathode
- (F): Extended Green Bialkali Photocathode

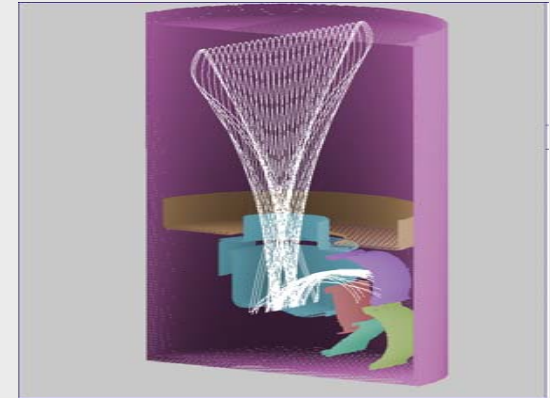
Bialkali:
Sb-Rb-Cs
Sb-K-Cs



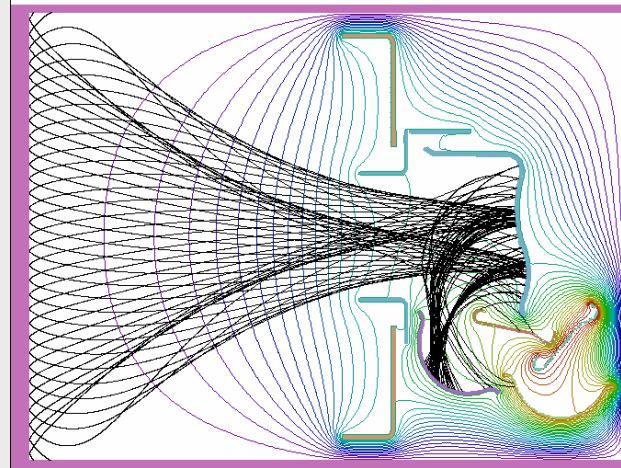
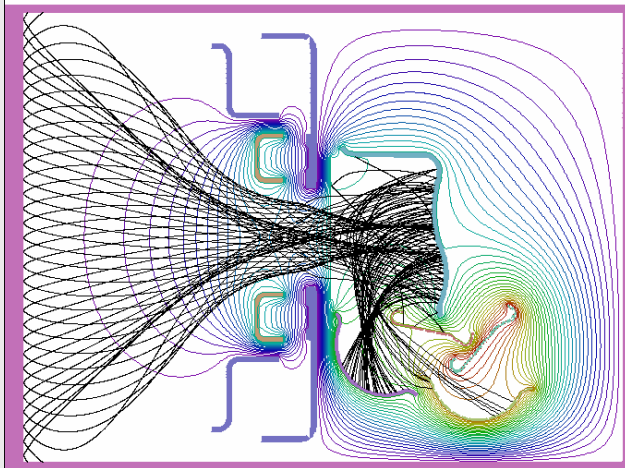


$$DQE \equiv \frac{(\# PE \text{ _ captured _ by _ 1st _ Dynode})}{(\# Incident \text{ _ Photons})}$$

$$= QE \cdot CE$$



It is not only important to convert photons into electrons : QE
 but also
 not to lose them before multiplication effect : CE



Note: there is no longer a mesh in the electron path. We get 10 % improvement.



$$DQE \equiv \frac{(\# PE \text{ _ captured _ by _ 1st _ Dynode})}{(\# Incident \text{ _ Photons})}$$

$$= QE \cdot CE$$

Another tube comparison :

XP1807 (12" – 11stage) and R8055 (13" – 10 stages):

New recent comparison from BAIKAL

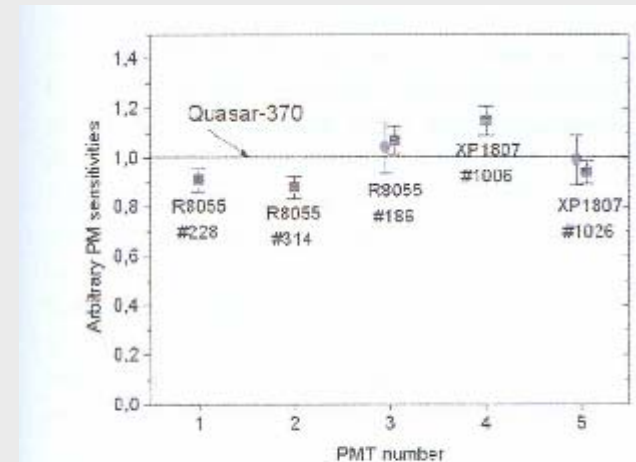
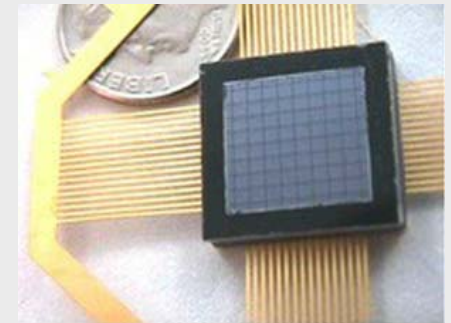
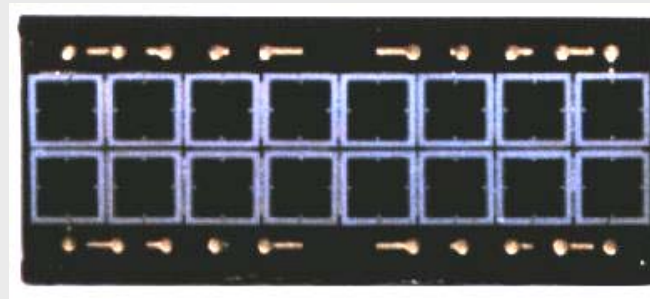
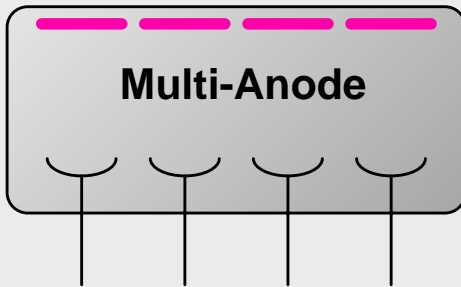


Figure 4: Ratio of effective sensitivity of large area PMs R8055/13" and XP1807/12" to QUASAR-370/14.6". Laboratory (squares), in-situ (dots).



DQE in pixellated detectors ...



For these detectors, another strong parameter kicks in :

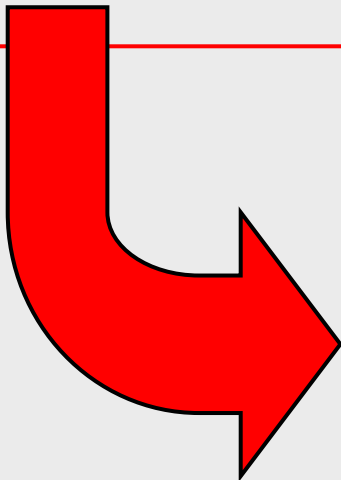
the actual active area

It is important to know how the QE is measured :

- **Dead area around Perimeter**
- **Dead area inside the active area**
(for example active area for SiPM is in the range 30% to 80% depending on design)



- ❑ QE : quantum efficiency : as high as possible (> 30 %)
- ❑ C_{ol} : collmecton efficiency : as close as possible to 100 % (> 0.9)
- ❑ ENF : « Excess Noise Factor » : as close as possible to 1.0 (<1.2)
- ❑ G : Gain (>> 10⁴)
- ❑ ENC : Electronic noise (1000 e⁻)
- ❑ N_{bg} (noise in photons of the detector) << N_γ (noumber of photons to detect)



$$\frac{\sigma}{E} = \frac{\sqrt{ENF \cdot QE \cdot C_{ol} (N_{\gamma} + N_{BG}) + (ENC/G)^2}}{QE \cdot C_{ol} \cdot N_{\gamma}}$$

$$\approx \sqrt{\frac{ENF}{QE \cdot C_{ol} \cdot N_{\gamma}}}$$



- Definition:

$$ENF \equiv \frac{\sigma_{Output}^2}{\sigma_{Input}^2}$$

Observed variance
Poisson predicted variance

- In case of PMT:

$$ENF = 1 + \frac{1}{\delta_1} + \frac{1}{\delta_1 \cdot \delta_2} + \dots + \frac{1}{\delta_1 \cdot \delta_2 \cdot \dots \cdot \delta_n}$$



PHR can also be improved by high D1 secondary emission

Other key parameters :

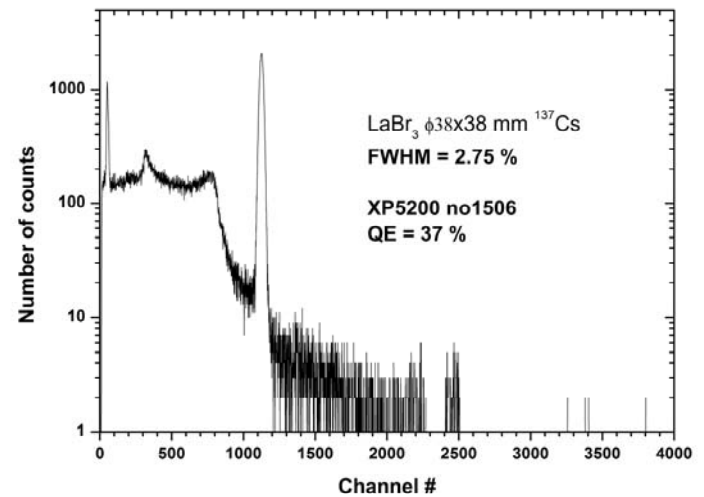
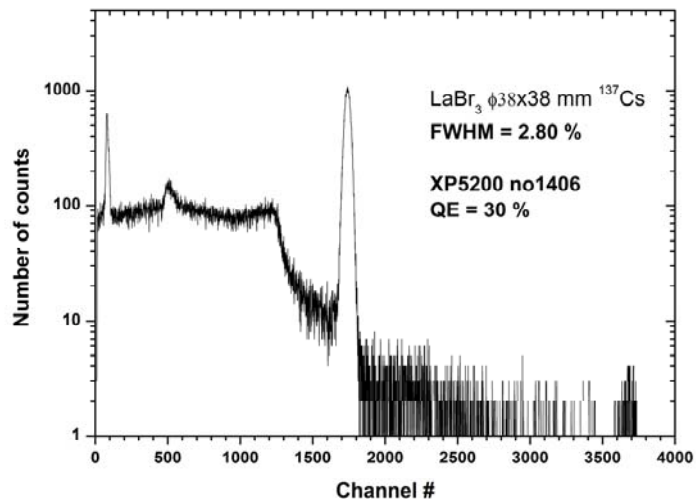
- Gain stability
- Afterpulse
- Linearity



Energy resolution and non-linearity

Key PMT characteristics for good PHR: (1) high QE of PC, (2) high and uniform secondary gain ...

2 PMTs type XP5200 with the QE of 37% and 30% for 420 nm





PMT size \Leftrightarrow cost

• Diameter	20"	\Leftrightarrow (20")17"	\Leftrightarrow 12"
• projected area	1660	1450	615 cm ²
• QE(typ)	20	20	24 %
• CE	60	60	70 %
• Cost	2500	2500	800 €
• <i>Cost/cm² per useful PE_U</i>	<i>= cost/(cm²xQExCE)</i>		
	12.6	14.4	7.7 €/PE _U /cm ²

Optimise !

Cost/cm² per useful area
PE_U=cost/(cm²xQExCE)

Talk from NNN 05 :
 Need to invest in high QE tube



Many applications require timing performance improvements :

Example 1 : HEP

Timing is key for particle identification in Cerenkov counters by J. VAVRA

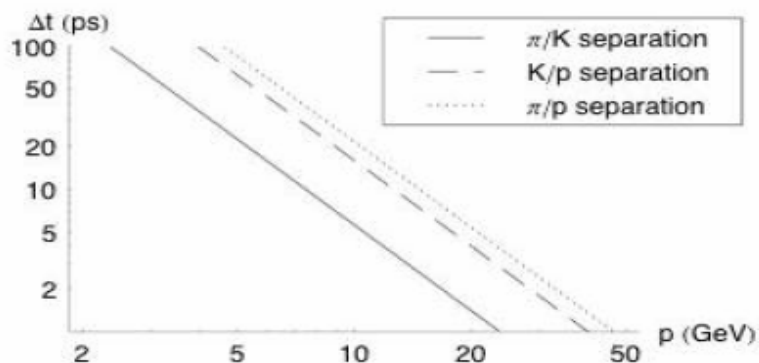


Fig. 1. The separations of pions, kaons, and protons, the difference in the time it takes two different particles with the same momentum to travel 1.5 m, as a function of momentum. Large time-of-flight detector systems have a time resolution on the order of 100 ps [2]-[4].

Need to go into psec time resolution
... MCP-PMT / SiPM

Example 2 : TOF - PET

Time-of-Flight in PET

By W. MOSES

New trends in PET instrumentation

Sept 18. 2006

- Use time-of-flight to localize source along line of flight.
- Time of flight information reduces noise in images.
- Variance reduction given by $2D/c\Delta t$.
- 500 ps timing resolution (equivalent to 7.5cm localisation) \Rightarrow 5x reduction in variance!

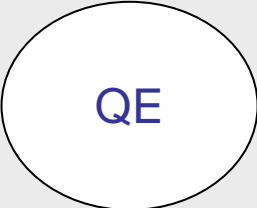
- Time of Flight Provides a Huge Performance Increase
 - Biggest Improvement in Large Patients



Many applications require timing performance improvements :

Parameter 1 of timing is photon statistics
(small dependance of wavelength) :

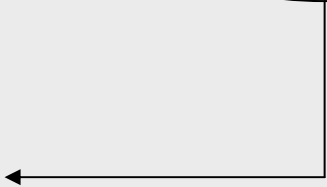
when light hitting the same photocathode location
time resolution is defined as FWHM of the probability distribution of the fluctuations ...
proportional to $1 / \sqrt{N}$ where N photoelectrons



Parameter 2 of timing is TTS specified by its standard deviation sigma :
distribution of the FMHW between PK locations
it includes the TTD between different PK locations



- TTS between PK and D1 (CE)
- TTS of the multiplier structure
- Effect of the voltage
- Anode design



See talk from M. Moszynski at IEEE 2007



Newest designs from Photonis allow reaching < 300 ps TTS for tubes 1" (XP1020) and 1.5" (XP3060)

For TOF PET; limitations of time resolution are now coming from scintillator statistics rather than PMT performance with leading edge trigger

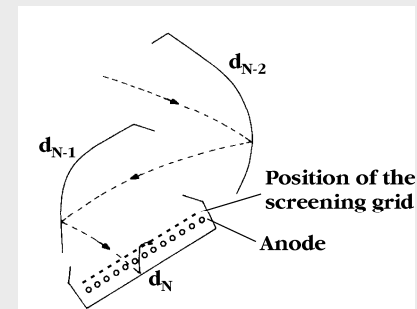
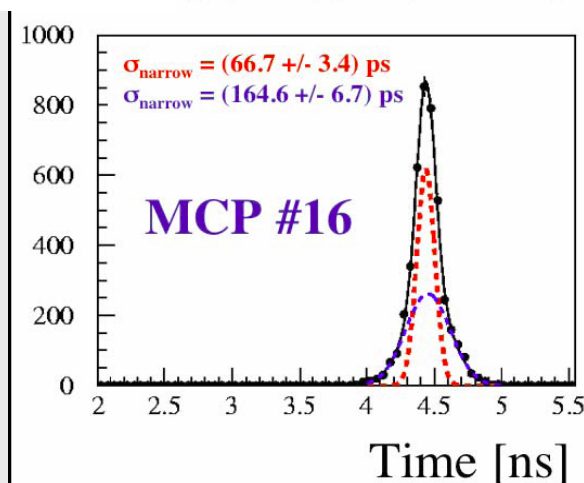
2" round, 8 stage for very fast timing :

XP20D0

TTS = 520 ps, 13.7 μ A/lmF, screening grid

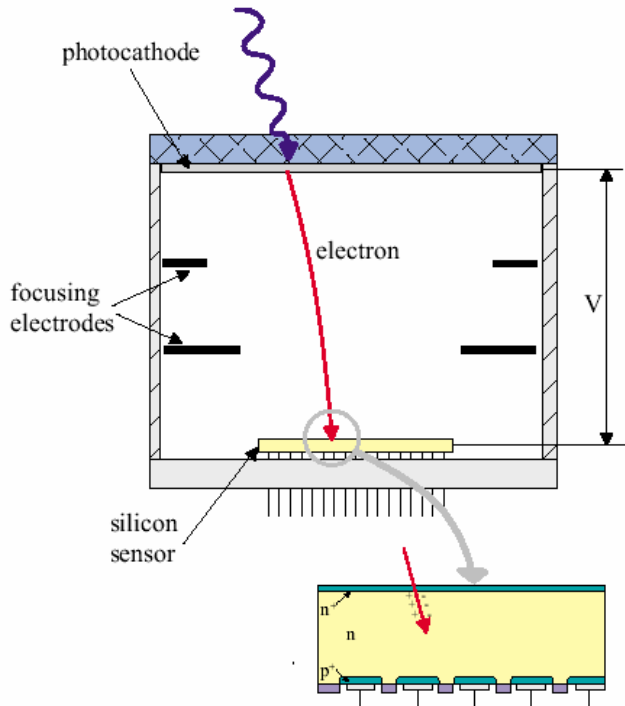
- LaBr₃ 154 \pm 5 ps
- LSO 166 \pm 5 ps

Photonis 85011-430 MCP-PMT:

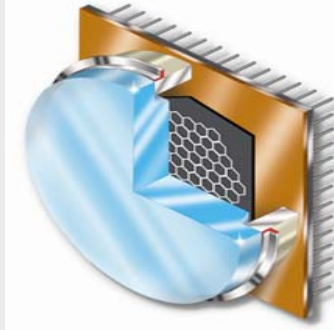
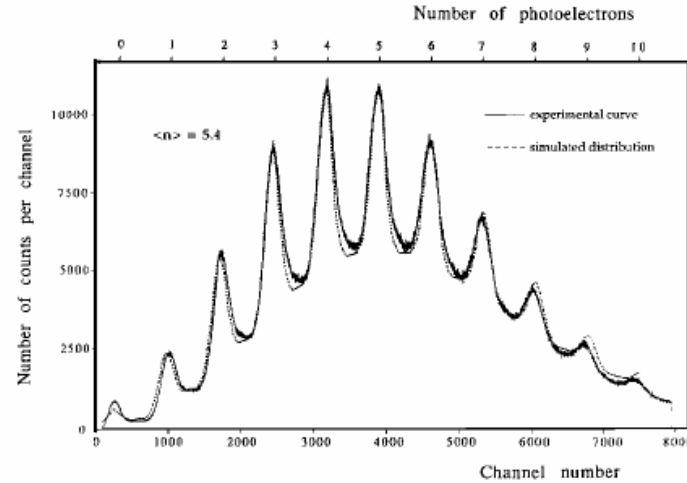




Interest : Additional noise while for PMTs noise is multiplying (no « Fano » factor)



Pair creation by **ionisation**
(3,6 eV / electron-hole pair for Si)



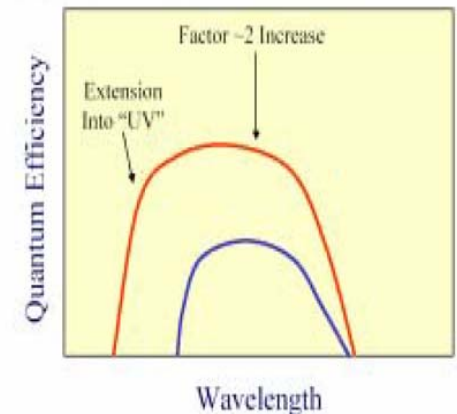
From JC VANEL
Prospectives IN2P3

Weakness of PMT & HPD : photocathode \rightarrow high QE !

Affinité électronique négative \rightarrow Semi-conducteur

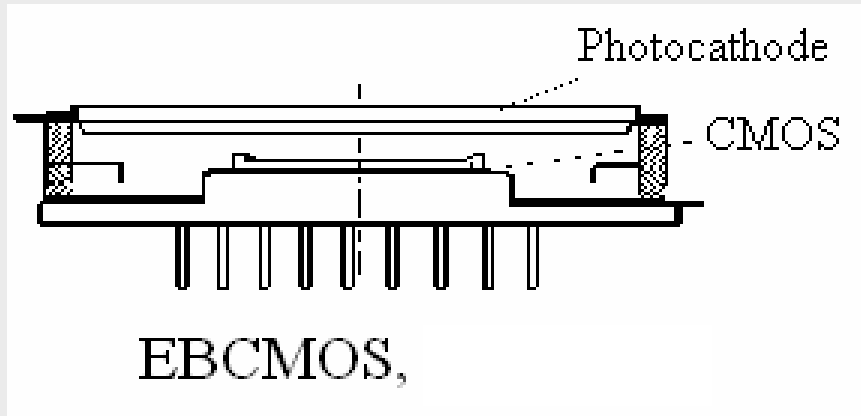
Multiple réflexion (filtre interférentiel).

Reflection Mode vs. Transmission Mode

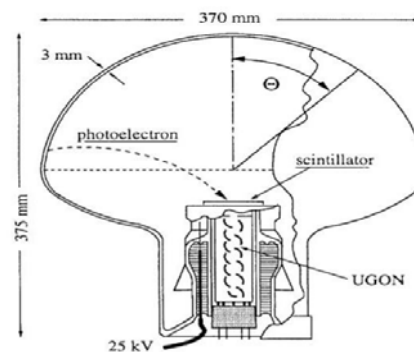




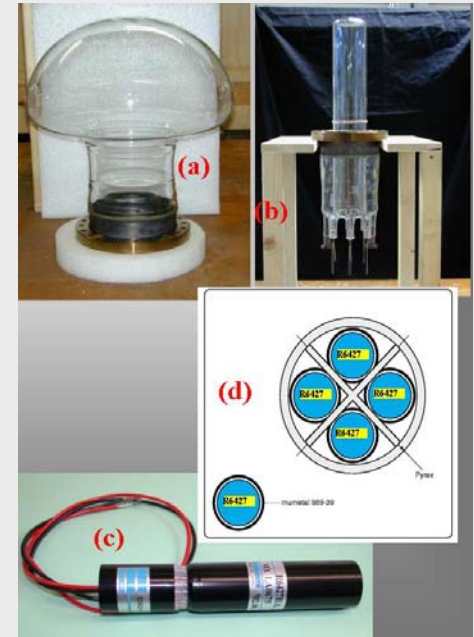
Another example of emerging new devices putting high QE photocathodes at the forefront of photodetection : EBCMOS



HPD for LHCb RICH counter



Baikai Quasar 370



**Hybrid PMT R&D
@ INFN Genova
(Marco Battaglieri et al;
NEMO/KM3NeT)**

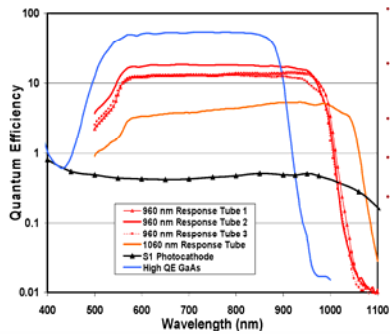


Status on high QE photocathodes :

Higher QE photocathodes exist since long ...



Results of Extended NIR Photocathodes

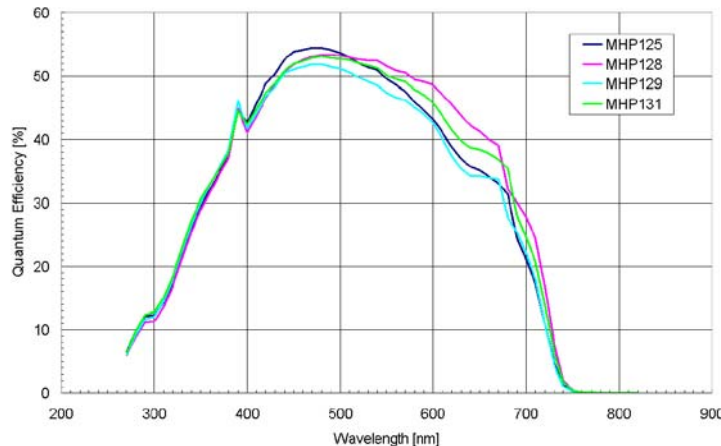


- Peak QE of 18% on 960 nm photocathode structure (13% at 960 nm)
- Peak QE of ~5% on 1060 nm photocathode structure (1% at 1060 nm)
- Further InGaAs material optimization possible
- UHV processing optimization possible
- Lower band gap and low lifetime affecting performance
 - Switching to lattice matched material could improve minority carrier properties
 - Lattice matched material would also remove visible cross hatch pattern

A few examples of high QE GaAs photocathodes :

QE above 40% at 420 nm are possible

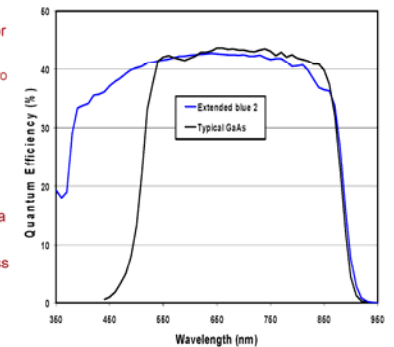
Photocathode(GaAsP) Spectral Response



R. MARZOYAN
GaAsP hybrids

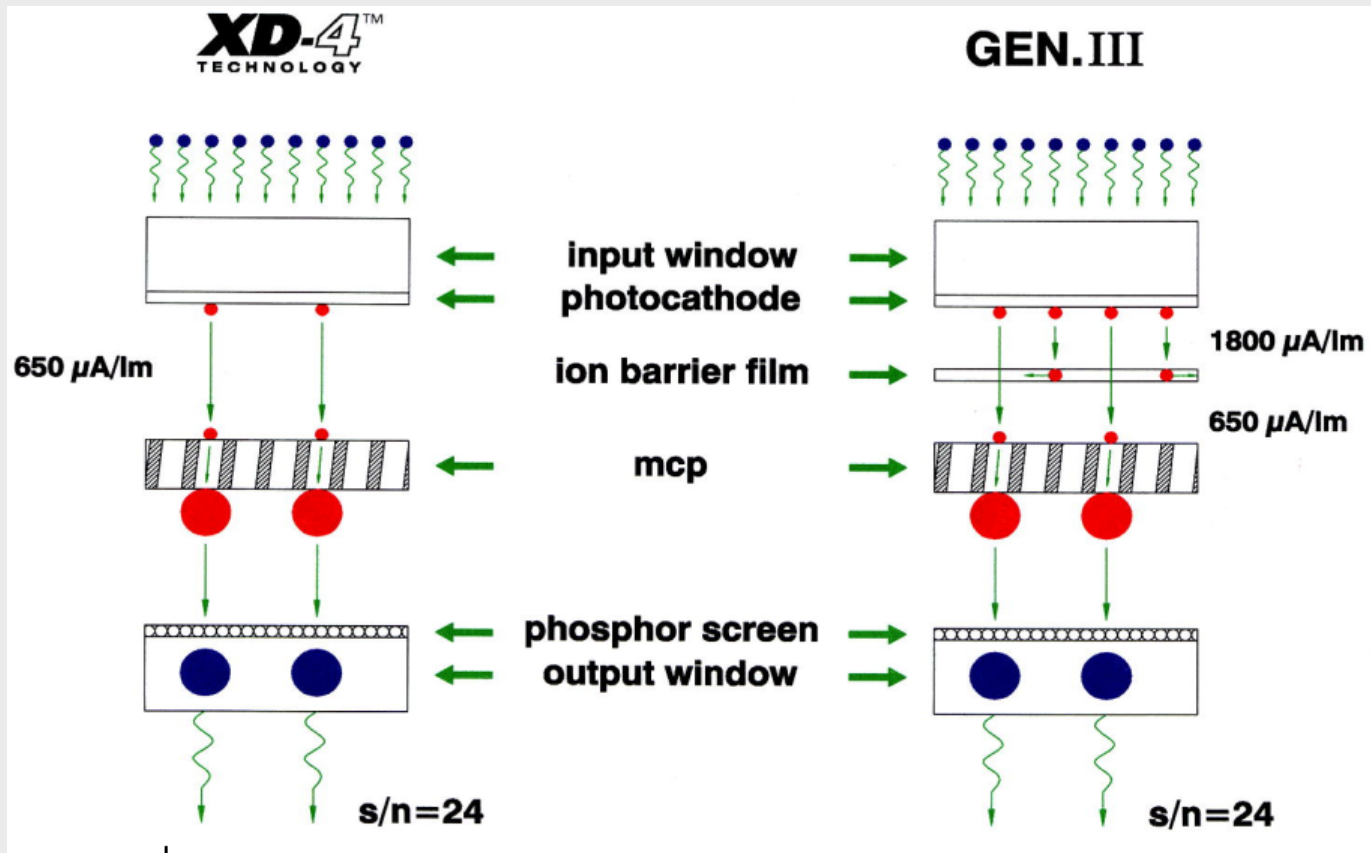
Extended Blue GaAs Photocathode

- Thinned the AlGaAs window layer for improved blue transmission
 - Thickness can not be reduced to zero as FSRV increases
- Applied most of the lessons learned from best GaAs photocathodes
- Used production process
 - Lower response but repeatable
- Lower red response is due to using a thinner photocathode
- Still not getting to cutoff of 7056 glass
 - Fall off in blue is 50 nm to soon



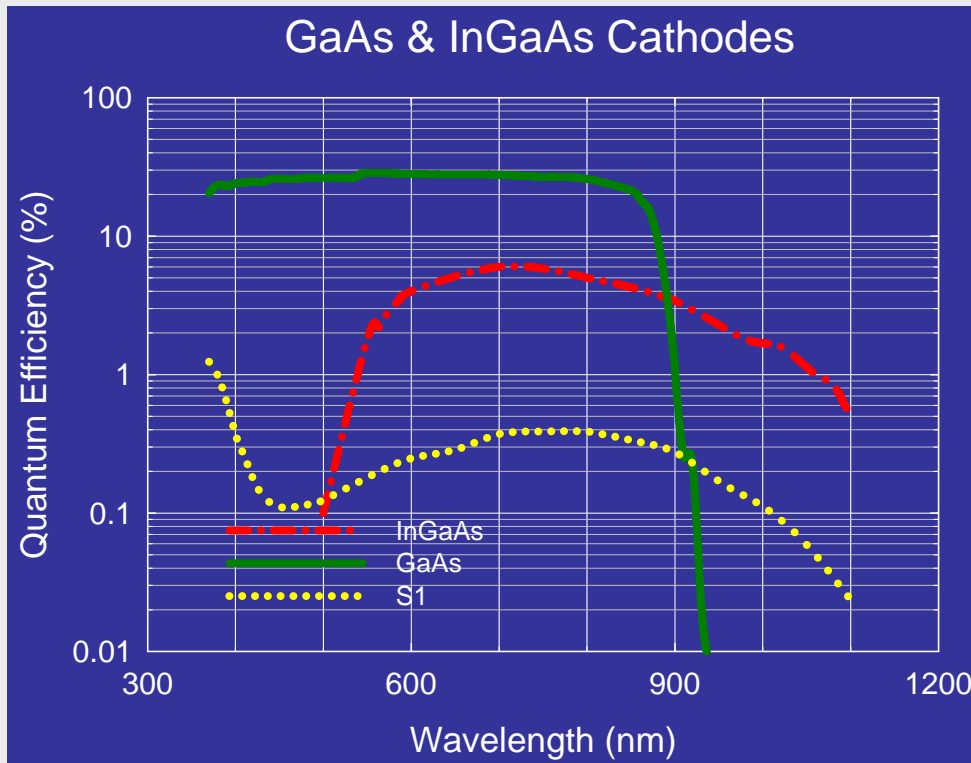


Third generation imaging tube : high QE vs S/N ratio (lifetime drawback)





High QE material exist in standard devices but strong link to technology ... and cost :



These materials require transfer photocathode processing which induces higher cost

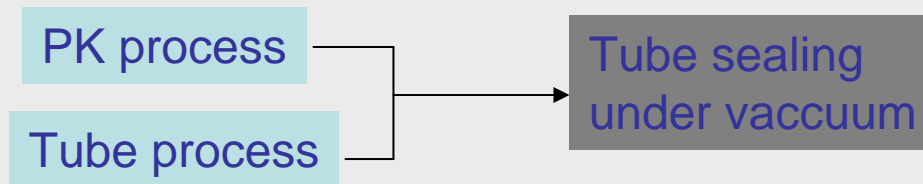


Interest in lower technological cost high QE solutions ... not transfer with the least technical drawbacks

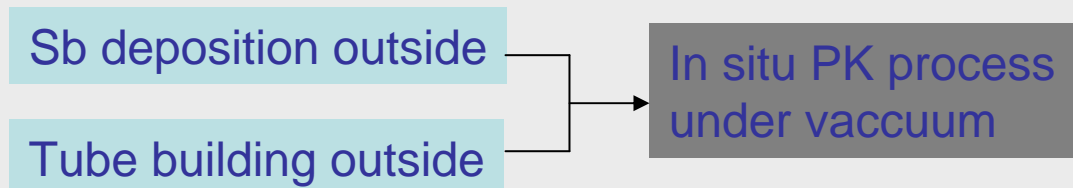


Proximity focussed designs allow only 2 types of PK process :

**1. Transfer photocathode
(PK processing separate from the tube and then seal ... high cost)**



**2. Pre-deposited
(Sb predeposition before processing ... low QE)**





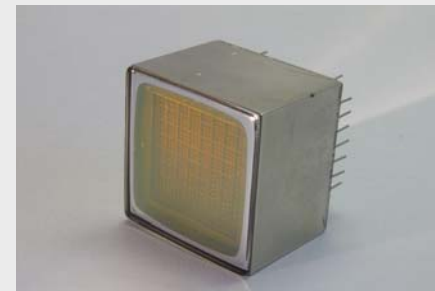
Multipixel tubes (2, 4, 9 channels)

- Widely used in high performance PET and PET-CT scanners
- High resolution, Excellent sensitivity, cost effective channels, Easy to tile
- WIP to reduce length by HALF
... these designs allow standard PMT processing

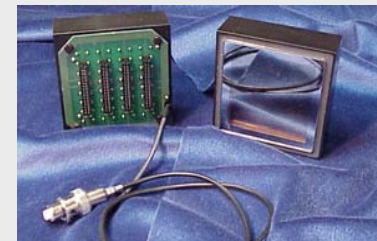


XP1422 XP1432 XP1452 XP1470

also available in PHOTONIS XP912064 :
11stage - 25mm square - 8 x 8 anodes
... these designs allow only lower QE
... high QE possible with transfer process



also available in PHOTONIS PLANACON XP85011 :
MCP-PMT - 51mm square – many read-out designs
... high QE possible because of transfer process

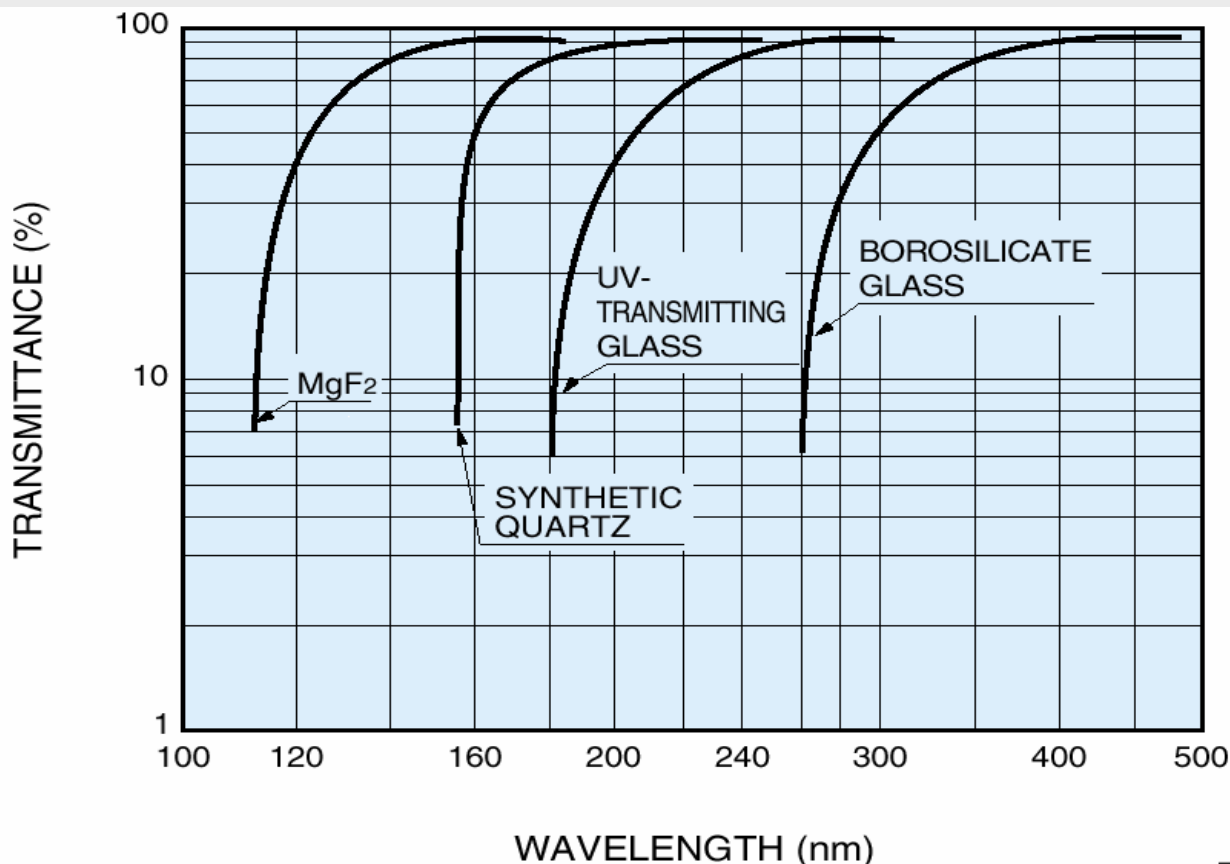




*How to improve intrinsic QE
in photomultiplier processing ?*



QE always include transmittance of Glass Window for vacuum devices



OPTIMISATION
by industry
(inside the tube) of :

Window Thickness

Window transmission

Window optical coupling to PK



What are the key parameters to increase photocathode QE ?

1. Surface structure and cleanliness :

Impact on photocathode growth & diffusion of impurities

2. Photocathode interface :

Optical coupling with entrance window

3. Photocathode material :

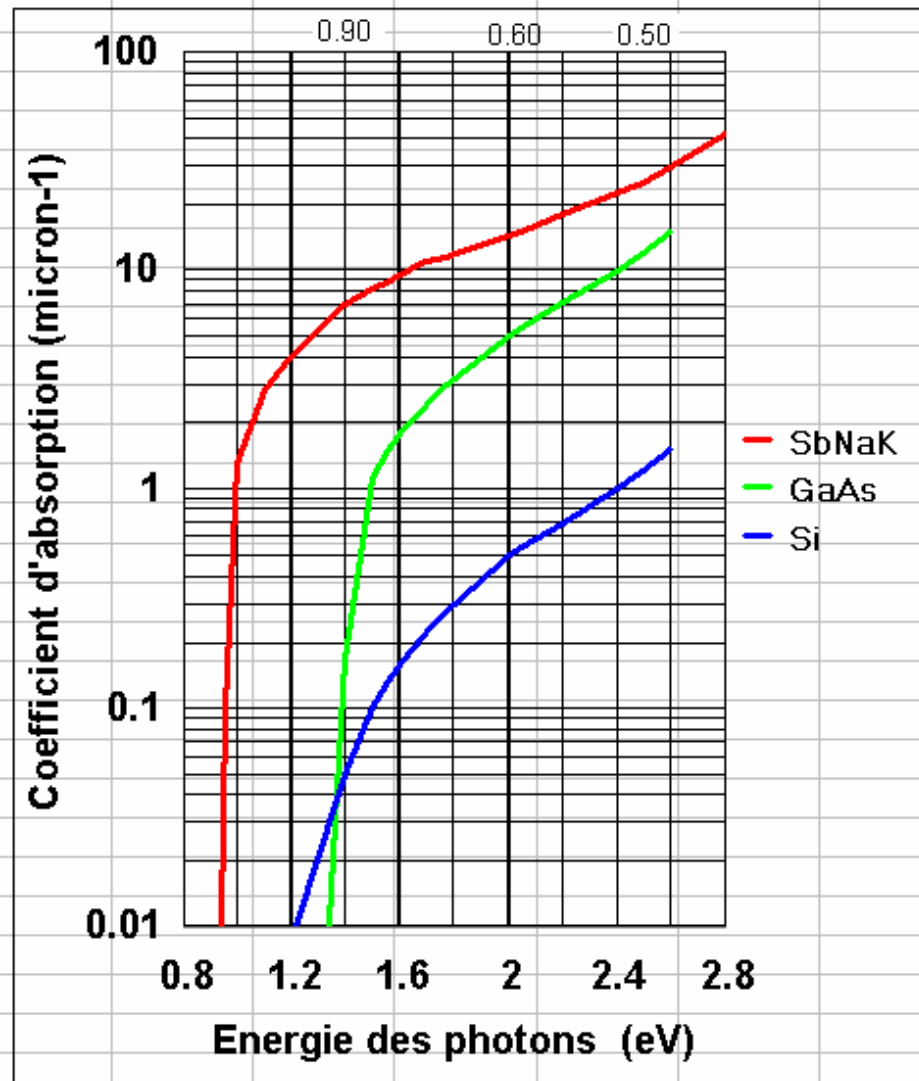
Purity of basic materials (dispensers) - Composition

4. Photocathode growth :

Growth defects – Uniformity – Band bending

5. Photocathode thickness :

Compromise absorption of photons – recombination of electrons



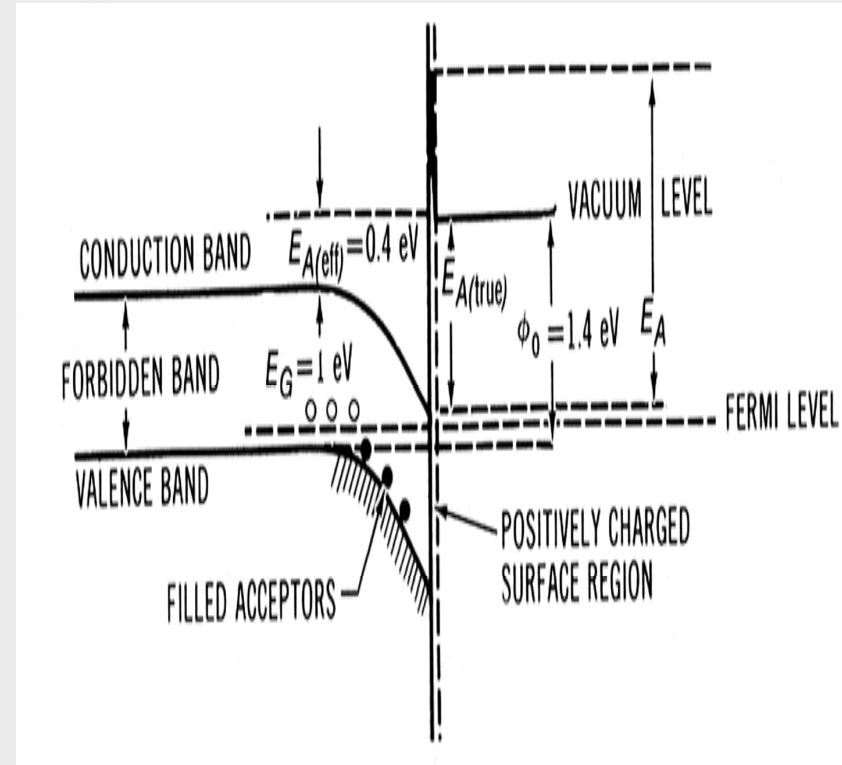
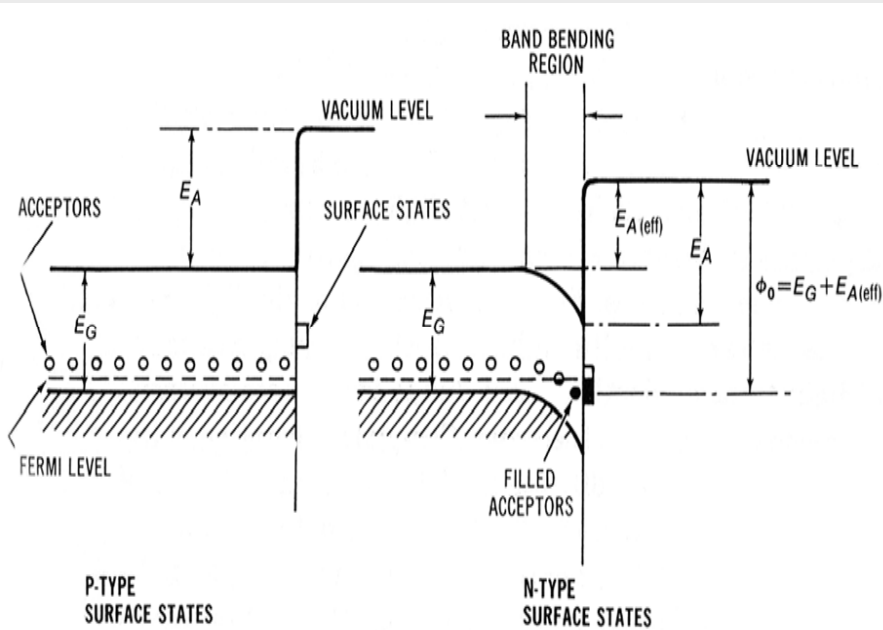


Depending on electron transport :

- Semiconductors with negative affinity :
 - Quick thermalisation of electrons to the bottom of the energy band
 - Thermal diffusion : long lifetime
 - → Diffusion length of a few μm
- Semiconductors with positive affinity :
 - Escape in vacuum has to occur before complete thermalisation
 - Time to be thermalised \ll lifetime at bottom of energy band
 - → Escaping depth $\sim 1000 \text{ nm}$



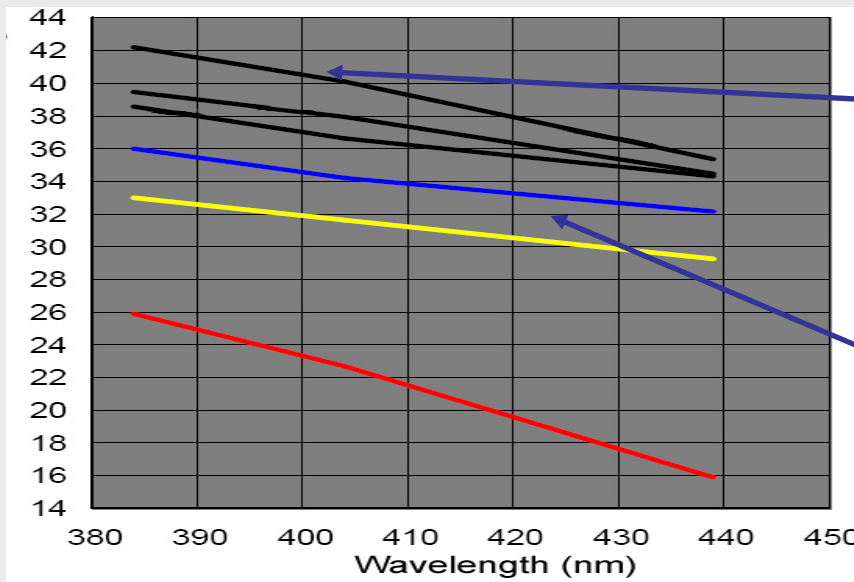
Surface barriers and band bending of multialkali photocathodes



Band bending required to reach > 50% QE



Different generations of bialkali PK and related QE performance level



Super² bialkali allow
Above 40% QE at 400 nm

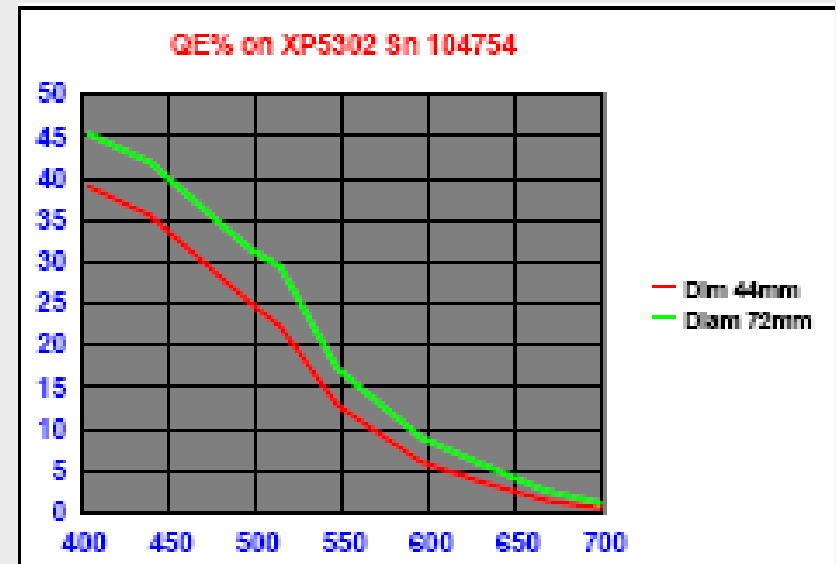
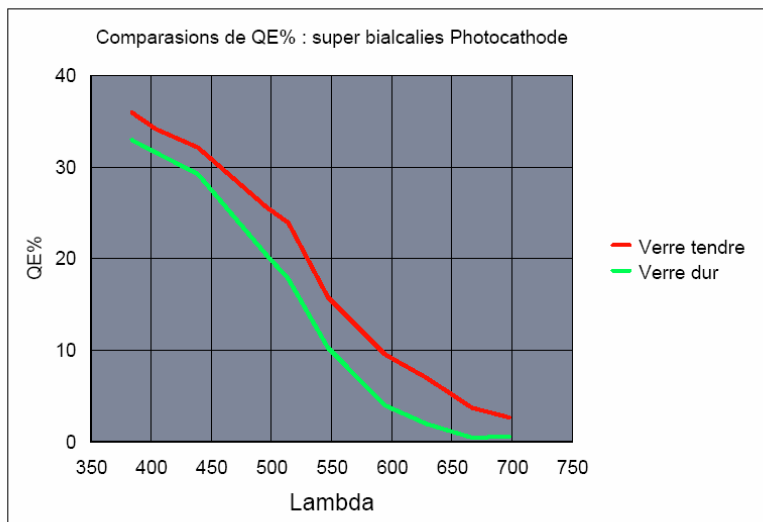
Super bialkali allow
35 – 40% QE at 400 nm

- Standard bialkali
- High End SPECT
- High End PET
- Sample n°1
- Sample n°2
- Sample n°3



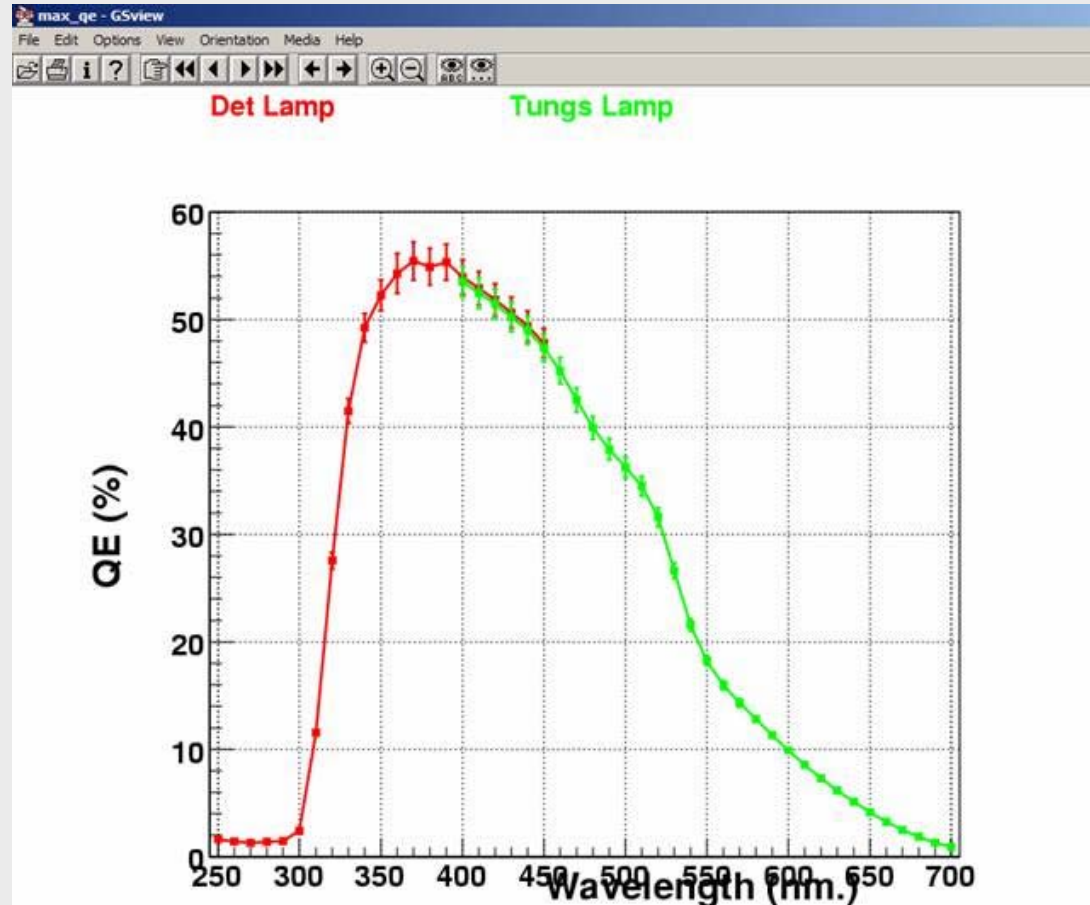
Super bialkali process
(400 nm 30 – 40%)

Super² bialkali process
(400 nm 40 – 50%)



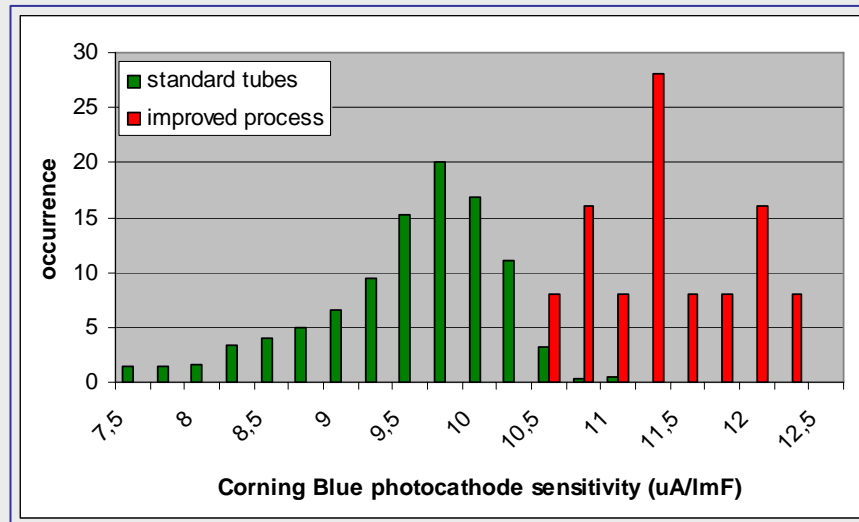


Super³ bialkali process
(400 nm 50 – 60%)





**The challenge is to master parameters and reduce production spread
in order
to produce a high ratio of high QE tubes**



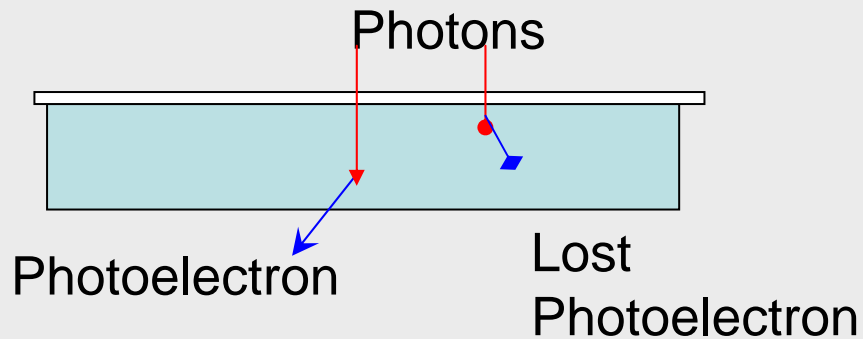
These high QE bialkali photocathodes are available on SPECT tubes and are being tuned to other types (dimensions, glass, metal can ...)

More production data on super² bialkali cathodes at IEEE in Hawaii in October 07

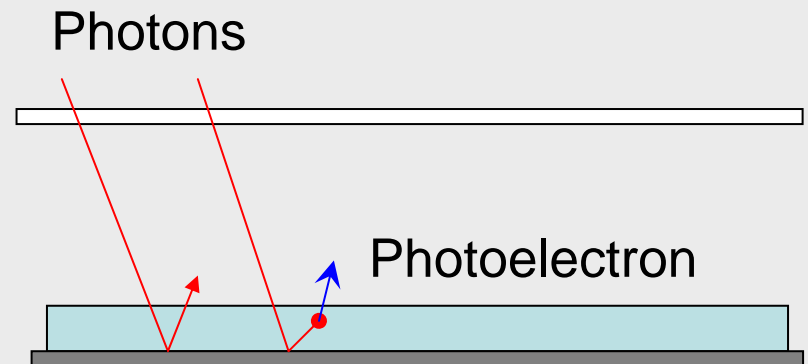


Improving overall QE of photodetectors ?

Thick Transmission
mode photocathode



Reflection mode
photocathode

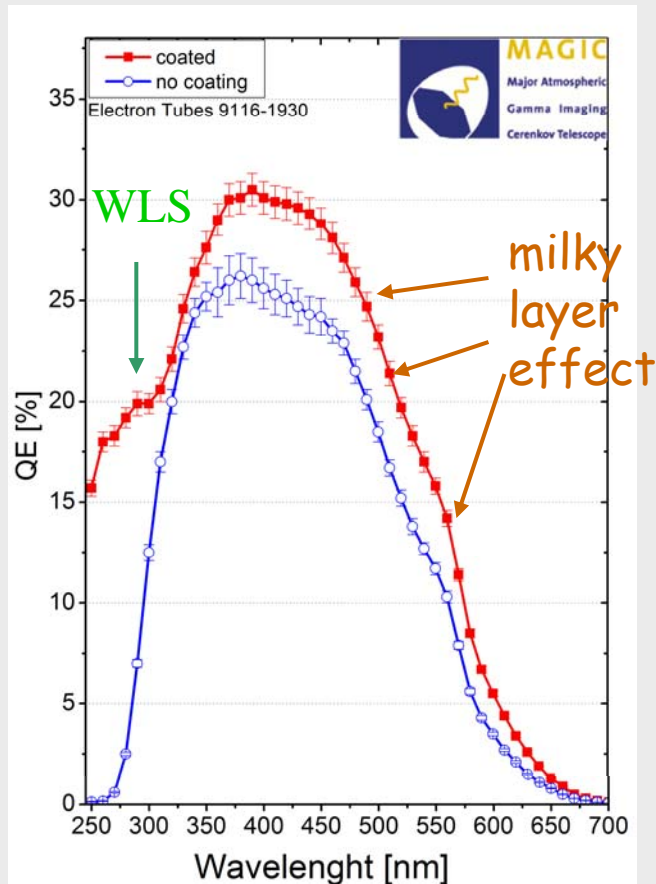




One example from physicists : PMTs of MAGIC-I

QE \uparrow by a diffuse scattering coating, +WLS

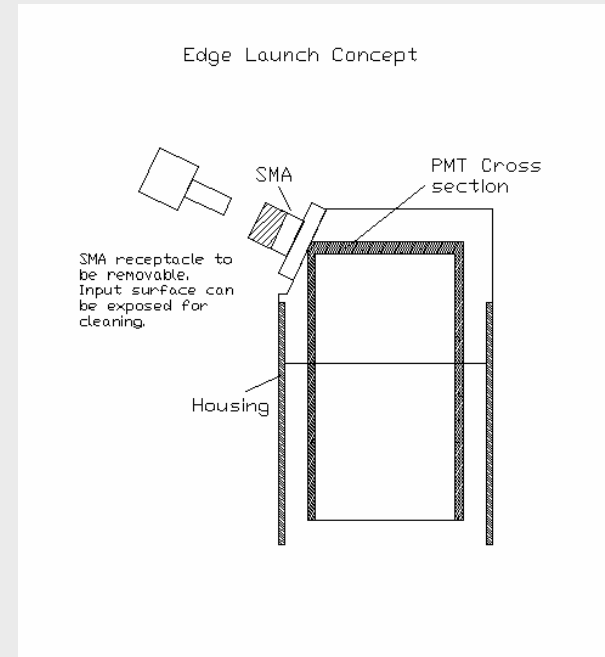
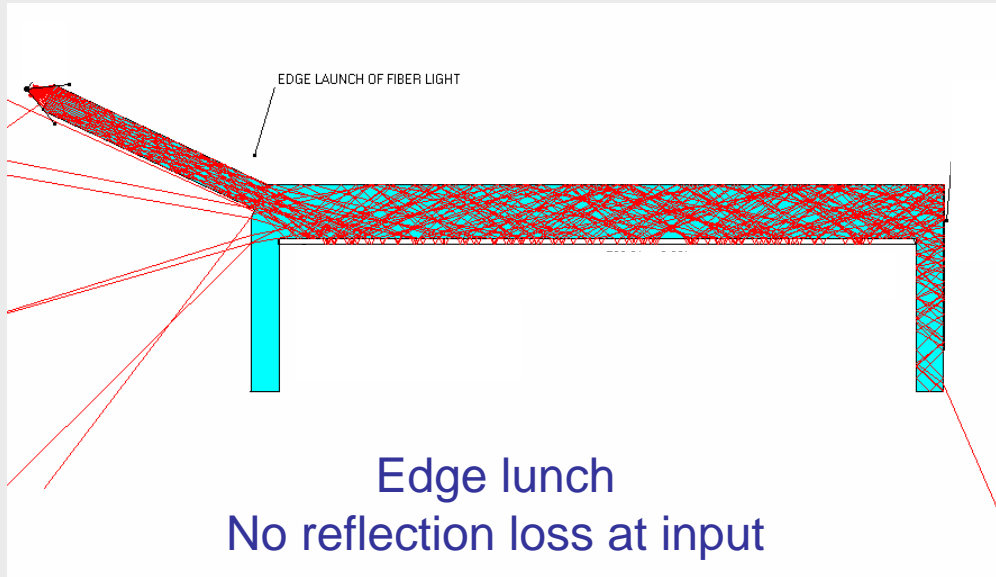
(D. Paneque, et al., 2002)



Effective QE \uparrow ~ 15 %



RED new PMT for spectrometers by TIR



It is characterized by broad spectral response covering the 300-850 nm wavelength range due to its unique fiber-optic input.

This sensor has improved signal-to-noise ratio.

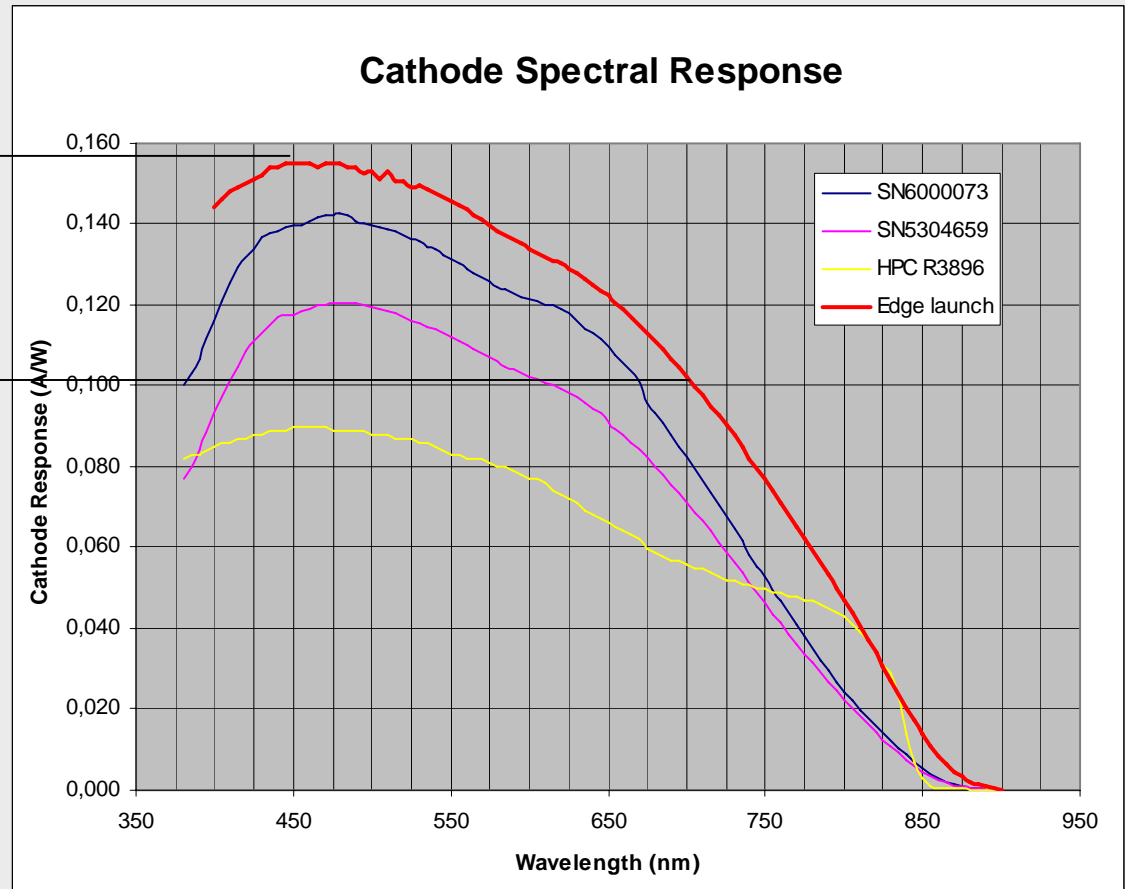


Improved Response with Edge Launch

QE of 43% at 450 nm

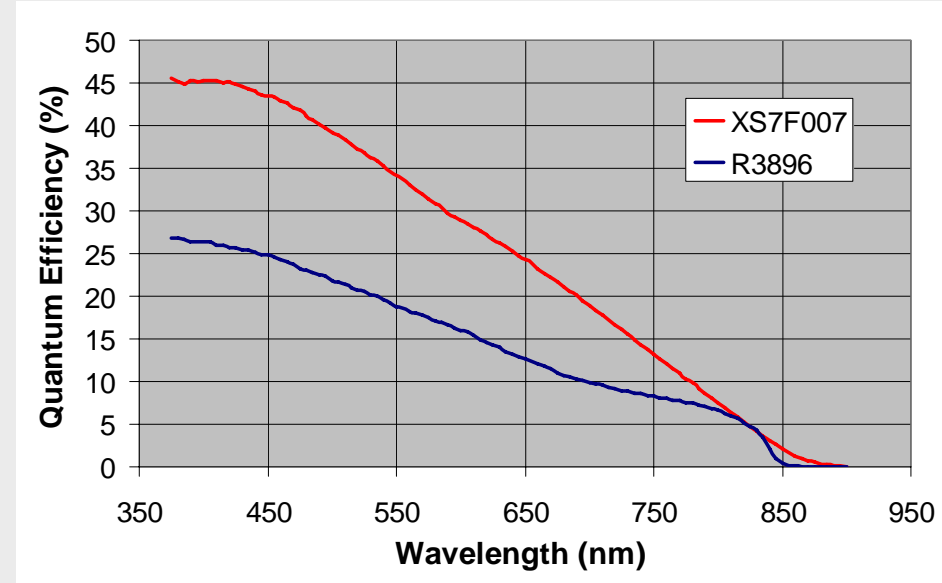
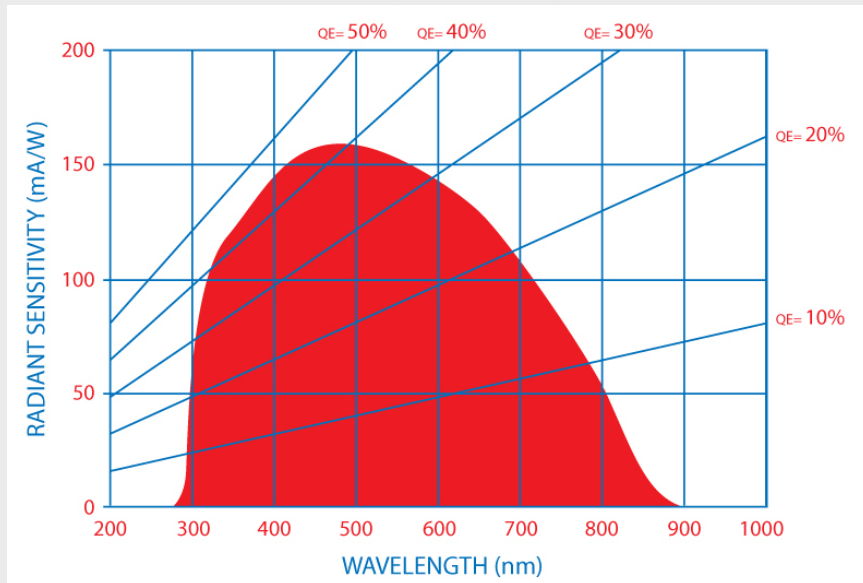
QE of 18% at 700 nm

Estimated White Light = 820 $\mu\text{A}/\text{lm}$





XS7F007 cathode spectral response



Important note :
QE increase by 30 to 40% by increasing the probability of interaction with PK
while dark current remained the same.



CONCLUSION :

1. QE is key for energy and time resolutions but other parameters participate
2. Intrinsic QE can reach above 50% at 420 nm
3. High QE availability require process adaptation and high manufacturability
4. There are many other key factors to consider and that must be also optimised in this process change
5. Overall QE can also be improved by TIR by 30 – 40 % at no dark curent expense
6. Together with the very efficient active area as well as other key parameters improvements, high QE PMTs are opening new limits for detection, energy and time resolution